

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination GADRE, MAKARAND	
		Examiner Zheng Wei	Art Unit 2192	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,405,368	06-2002	Freyburger, Brian	717/140
*	C	US-6,018,628	01-2000	Stoutamire, David P.	717/147
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	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	Eric Allen, Diagnosing Java Code: Java generics without the pain, Parts1,2, published by IBM, 05/20/2003, pages 1-12
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.